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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	RL78
Core Size	16-Bit
Speed	32MHz
Connectivity	CSI, I <sup>2</sup> C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	48
Program Memory Size	48KB (48K x 8)
Program Memory Type	FLASH
EPROM Size	-
RAM Size	3K x 8
oltage - Supply (Vcc/Vdd)	1.6V ~ 5.5V
ata Converters	A/D 12x8/10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
ackage / Case	64-LQFP
Supplier Device Package	64-LFQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f101ldafb-v0

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RL78/G13 1. OUTLINE

Table 1-1. List of Ordering Part Numbers

(2/12)

D:	D/	·	Fig. 6	(2/12)
Pin	Package	Data	Fields of	Ordering Part Number
count		flash	Application	
			Note	
25 pins	25-pin plastic	Mounted	Α	R5F1008AALA#U0, R5F1008CALA#U0, R5F1008DALA#U0,
25 piris		Mounted	, ,	R5F1008EALA#U0
	WFLGA ( $3 \times 3$ mm,			R5F1008AALA#W0, R5F1008CALA#W0, R5F1008DALA#W0,
	0.5 mm pitch)			R5F1008EALA#W0
	. ,		G	
			G	R5F1008AGLA#U0, R5F1008CGLA#U0, R5F1008DGLA#U0,
				R5F1008EGLA#U0
				R5F1008AGLA#W0, R5F1008CGLA#W0, R5F1008DGLA#W0,
			_	R5F1008EGLA#W0
		Not	Α	R5F1018AALA#U0, R5F1018CALA#U0, R5F1018DALA#U0,
		mounted		R5F1018EALA#U0
				R5F1018AALA#W0, R5F1018CALA#W0, R5F1018DALA#W0,
				R5F1018EALA#W0
30 pins	30-pin plastic LSSOP	Mounted	Α	R5F100AAASP#V0, R5F100ACASP#V0, R5F100ADASP#V0,
00 p0	(7.62 mm (300), 0.65			R5F100AEASP#V0, R5F100AFASP#V0, R5F100AGASP#V0
				R5F100AAASP#X0, R5F100ACASP#X0, R5F100ADASP#X0
	mm pitch)			R5F100AEASP#X0, R5F100AFASP#X0, R5F100AGASP#X0
			D	R5F100AADSP#V0, R5F100ACDSP#V0, R5F100ADDSP#V0,
				R5F100AEDSP#V0, R5F100AFDSP#V0, R5F100AGDSP#V0
				R5F100AADSP#X0, R5F100ACDSP#X0, R5F100ADDSP#X0,
				R5F100AEDSP#X0, R5F100AFDSP#X0, R5F100AGDSP#X0
			G	
			G	R5F100AAGSP#V0, R5F100ACGSP#V0,
				R5F100ADGSP#V0,R5F100AEGSP#V0,
				R5F100AFGSP#V0, R5F100AGGSP#V0
				R5F100AAGSP#X0, R5F100ACGSP#X0,
				R5F100ADGSP#X0,R5F100AEGSP#X0,
				R5F100AFGSP#X0, R5F100AGGSP#X0
		Not	Α	R5F101AAASP#V0, R5F101ACASP#V0, R5F101ADASP#V0,
		mounted		R5F101AEASP#V0, R5F101AFASP#V0, R5F101AGASP#V0
				R5F101AAASP#X0, R5F101ACASP#X0, R5F101ADASP#X0,
				R5F101AEASP#X0, R5F101AFASP#X0, R5F101AGASP#X0
			D	R5F101AADSP#V0, R5F101ACDSP#V0, R5F101ADDSP#V0,
				R5F101AEDSP#V0, R5F101AFDSP#V0, R5F101AGDSP#V0
				R5F101AADSP#X0, R5F101ACDSP#X0, R5F101ADDSP#X0,
				R5F101AEDSP#X0, R5F101AFDSP#X0, R5F101AGDSP#X0
32 pins	32-pin plastic	Mounted	Α	R5F100BAANA#U0, R5F100BCANA#U0, R5F100BDANA#U0,
32 pins		Mounted		R5F100BEANA#U0, R5F100BFANA#U0, R5F100BGANA#U0
	HWQFN (5 $\times$ 5 mm,			R5F100BAANA#W0, R5F100BCANA#W0, R5F100BDANA#W0,
	0.5 mm pitch)			R5F100BEANA#W0, R5F100BFANA#W0, R5F100BGANA#W0
			D	R5F100BADNA#U0, R5F100BCDNA#U0, R5F100BDDNA#U0,
			D	, , , , , , , , , , , , , , , , , , , ,
		1		R5F100BEDNA#U0, R5F100BFDNA#U0, R5F100BGDNA#U0
		1		R5F100BADNA#W0, R5F100BCDNA#W0, R5F100BDDNA#W0,
		1		R5F100BEDNA#W0, R5F100BFDNA#W0, R5F100BGDNA#W0
		1	G	R5F100BAGNA#U0, R5F100BCGNA#U0, R5F100BDGNA#U0,
		1		R5F100BEGNA#U0, R5F100BFGNA#U0, R5F100BGGNA#U0
		1		R5F100BAGNA#W0, R5F100BCGNA#W0, R5F100BDGNA#W0,
				R5F100BEGNA#W0, R5F100BFGNA#W0, R5F100BGGNA#W0
		Not	Α	R5F101BAANA#U0, R5F101BCANA#U0, R5F101BDANA#U0,
				R5F101BEANA#U0, R5F101BFANA#U0, R5F101BGANA#U0
		mounted		R5F101BAANA#W0, R5F101BCANA#W0, R5F101BDANA#W0,
		1		R5F101BEANA#W0, R5F101BFANA#W0, R5F101BGANA#W0
1		1	D	R5F101BADNA#U0, R5F101BCDNA#U0, R5F101BDDNA#U0,
1		1		R5F101BEDNA#U0, R5F101BFDNA#U0, R5F101BGDNA#U0
1				·
		]		R5F101BADNA#W0, R5F101BCDNA#W0, R5F101BDDNA#W0,
		1		R5F101BEDNA#W0, R5F101BFDNA#W0, R5F101BGDNA#W0

Note For the fields of application, refer to Figure 1-1 Part Number, Memory Size, and Package of RL78/G13.

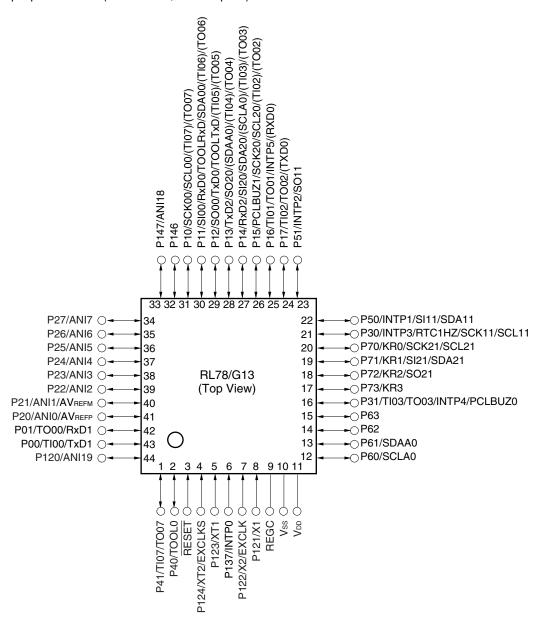
Caution The ordering part numbers represent the numbers at the time of publication. For the latest ordering part numbers, refer to the target product page of the Renesas Electronics website.



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### 1.3.8 44-pin products

• 44-pin plastic LQFP (10 × 10 mm, 0.8 mm pitch)



Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1  $\mu$ F).

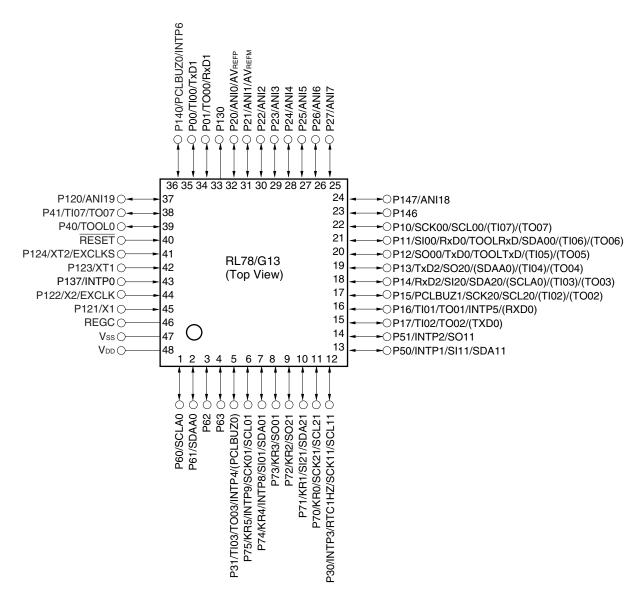
Remarks 1. For pin identification, see 1.4 Pin Identification.

Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR). Refer to Figure 4-8 Format of Peripheral I/O Redirection Register (PIOR) in the RL78/G13 User's Manual.

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## 1.3.9 48-pin products

• 48-pin plastic LFQFP (7 x 7 mm, 0.5 mm pitch)



Caution Connect the REGC pin to Vss via a capacitor (0.47 to 1  $\mu$ F).

Remarks 1. For pin identification, see 1.4 Pin Identification.

Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR). Refer to Figure 4-8 Format of Peripheral I/O Redirection Register (PIOR) in the RL78/G13 User's Manual.

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#### 1.6 Outline of Functions

[20-pin, 24-pin, 25-pin, 30-pin, 32-pin, 36-pin products]

Caution This outline describes the functions at the time when Peripheral I/O redirection register (PIOR) is set to 00H.

(1/2)

												(1/2	
	Item	20-	pin	24-	-pin	25	-pin	30-	pin	32-	pin	36-	pin
		R5F1006x	R5F1016x	R5F1007x	R5F1017x	R5F1008x	R5F1018x	R5F100Ax	R5F101Ax	R5F100Bx	R5F101Bx	R5F100Cx	R5F101Cx
Code flash me	emory (KB)	16 to	64	16 t	o 64	16 t	o 64	16 to	128	16 to	128	16 to	128
Data flash me	mory (KB)	4	=	4	_	4	-	4 to 8	=	4 to 8	-	4 to 8	=
RAM (KB)		2 to	4 <sup>Note1</sup>	2 to	4 <sup>Note1</sup>	2 to	4 <sup>Note1</sup>	2 to 1	12 <sup>Note1</sup>	2 to 1	12 <sup>Note1</sup>	2 to 1	2 <sup>Note1</sup>
Address space	e	1 MB											
Main system clock	High-speed system clock	HS (Hig HS (Hig LS (Low	h-speed h-speed v-speed	l main) m I main) m main) m	node: 1 t node: 1 t ode: 1 to	o 20 M⊢ o 16 M⊢ o 8 MHz	main sys Iz (V <sub>DD</sub> = Iz (V <sub>DD</sub> = (V <sub>DD</sub> = 1. z (V <sub>DD</sub> = 1	2.7 to 5. 2.4 to 5. 8 to 5.5	5 V), 5 V), V),	EXCLK)			
	High-speed on-chip oscillator	HS (Hig LS (Lov	h-speed v-speed	l main) m main) m	node: 1 t ode: 1 t	:o 16 MH :o 8 MHz	dz (Vdd = dz (Vdd = z (Vdd = 1 z (Vdd = 1	2.4 to 5.5	.5 V), 5 V),				
Subsystem clo	ock		-										
Low-speed on	-chip oscillator	15 kHz (TYP.)											
General-purpo	ose registers	(8-bit register × 8) × 4 banks											
Minimum instr	ruction execution time	0.03125	μs (Hig	h-speed	on-chip	oscillato	or: fін = 32	2 MHz o <sub>l</sub>	peration	)			
		0.05 $\mu$ s (High-speed system clock: $f_{MX}$ = 20 MHz operation)											
Instruction set		<ul> <li>Data transfer (8/16 bits)</li> <li>Adder and subtractor/logical operation (8/16 bits)</li> <li>Multiplication (8 bits × 8 bits)</li> <li>Rotate, barrel shift, and bit manipulation (Set, reset, test, and Boolean operation), etc.</li> </ul>											
I/O port	Total	1	6	2	.0	2	21	2	6	2	8	3	2
	CMOS I/O	(N-ch C (V <sub>DD</sub> wit voltag	D.D. I/O hstand	(N-ch C	5 D.D. I/O thstand ge]: 6)	(N-ch (	D.D. I/O thstand ge]: 6)	2 (N-ch C [V <sub>DD</sub> with voltage	D.D. I/O thstand	2 (N-ch C [V <sub>DD</sub> wi <sup>1</sup> voltag	thstand	(N-ch C [V <sub>DD</sub> wit voltage	D.D. I/O thstand
	CMOS input	3	3	(	3	;	3	3	3	3	3	3	3
	CMOS output	=	-	-	=		1	=	=	=	=	=	=
	N-ch O.D. I/O (withstand voltage: 6 V)	-	-	2	2	:	2	2	2	3	3	3	3
Timer	16-bit timer						8 cha	nnels					
	Watchdog timer						1 cha	ınnel					
	Real-time clock (RTC)						1 chanı	nel Note 2					
	12-bit interval timer (IT)						1 cha	ınnel					
	Timer output	3 chann (PWM c 2 Note 3)		4 chanr (PWM	nels outputs:	3 Note 3)				M output			
	RTC output						_	-					

Notes 1. The flash library uses RAM in self-programming and rewriting of the data flash memory.

The target products and start address of the RAM areas used by the flash library are shown below.

R5F100xD, R5F101xD (x = 6 to 8, A to C): Start address FF300H R5F100xE, R5F101xE (x = 6 to 8, A to C): Start address FEF00H

For the RAM areas used by the flash library, see Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944).

2. Only the constant-period interrupt function when the low-speed on-chip oscillator clock (fill) is selected

#### 2.2 Oscillator Characteristics

#### 2.2.1 X1, XT1 oscillator characteristics

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le V_{DD} \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$ 

Parameter	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation	Ceramic resonator/	$2.7~V \leq V_{DD} \leq 5.5~V$	1.0		20.0	MHz
frequency (fx) <sup>Note</sup>	crystal resonator	$2.4~V \leq V_{DD} < 2.7~V$	1.0		16.0	MHz
		$1.8~V \leq V_{DD} < 2.4~V$	1.0		8.0	MHz
		$1.6~V \leq V_{DD} < 1.8~V$	1.0		4.0	MHz
XT1 clock oscillation frequency (fx) <sup>Note</sup>	Crystal resonator		32	32.768	35	kHz

**Note** Indicates only permissible oscillator frequency ranges. Refer to AC Characteristics for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

Remark When using the X1 oscillator and XT1 oscillator, refer to 5.4 System Clock Oscillator.

#### 2.2.2 On-chip oscillator characteristics

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{Vss} = 0 \text{ V})$ 

(12 10 10 100 0, 110 1	1	10 1, 100 0 1,	,			1	1
Oscillators	Parameters		Conditions	MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency Notes 1, 2	fıн			1		32	MHz
High-speed on-chip oscillator		–20 to +85 °C	$1.8~V \leq V_{DD} \leq 5.5~V$	-1.0		+1.0	%
clock frequency accuracy			$1.6~V \le V_{DD} < 1.8~V$	-5.0		+5.0	%
		–40 to –20 °C	$1.8~V \leq V_{DD} \leq 5.5~V$	-1.5		+1.5	%
			$1.6~V \le V_{DD} < 1.8~V$	-5.5		+5.5	%
Low-speed on-chip oscillator clock frequency	fiL				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				-15		+15	%

**Notes 1.** High-speed on-chip oscillator frequency is selected by bits 0 to 3 of option byte (000C2H/010C2H) and bits 0 to 2 of HOCODIV register.

2. This indicates the oscillator characteristics only. Refer to AC Characteristics for instruction execution time.

# (2) Flash ROM: 96 to 256 KB of 30- to 100-pin products

# (Ta = -40 to +85°C, 1.6 V $\leq$ EVDD0 = EVDD1 $\leq$ VDD $\leq$ 5.5 V, Vss = EVss0 = EVss1 = 0 V) (2/2)

Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Unit
	DD2	HALT	HS (high-	fin = 32 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.62	1.86	mA
	mode	speed main) mode Note 7		V <sub>DD</sub> = 3.0 V		0.62	1.86	mA	
	ply IDD2 HALT	mode	fih = 24 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.50	1.45	mA	
					V <sub>DD</sub> = 3.0 V		0.50	1.45	mA
				fih = 16 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.44	1.11	mA
					V <sub>DD</sub> = 3.0 V		0.44	1.11	mA
			LS (low-	fin = 8 MHz Note 4	V <sub>DD</sub> = 3.0 V		290	620	μA
			speed main) mode Note 7		V <sub>DD</sub> = 2.0 V		290	620	μΑ
			LV (low-	f <sub>IH</sub> = 4 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V		440	680	μΑ
			voltage main) mode		V <sub>DD</sub> = 2.0 V		440	680	μΑ
			HS (high-	f <sub>MX</sub> = 20 MHz <sup>Note 3</sup> ,	Square wave input		0.31	1.08	mA
			speed main) mode Note 7	V <sub>DD</sub> = 5.0 V	Resonator connection		0.48	1.28	mA
				$f_{MX} = 20 \text{ MHz}^{\text{Note 3}},$	Square wave input		0.31	1.08	mA
				V <sub>DD</sub> = 3.0 V	Resonator connection		0.48	1.28	mA
				$f_{MX} = 10 \text{ MHz}^{\text{Note 3}},$	Square wave input		0.21	0.63	mA
			V <sub>DD</sub> = 5.0 V	Resonator connection		0.28	0.71	mA	
			f <sub>M</sub> x = 10 MHz <sup>Note 3</sup> ,	Square wave input		0.21	0.63	mA	
			V <sub>DD</sub> = 3.0 V	Resonator connection		0.28	0.71	mA	
		LS (low-	$f_{MX} = 8 MHz^{Note 3},$	Square wave input		110	360	μΑ	
			speed main) mode Note 7	V <sub>DD</sub> = 3.0 V	Resonator connection		160	420	μΑ
				fmx = 8 MHz <sup>Note 3</sup> ,	Square wave input		110	360	μΑ
				V <sub>DD</sub> = 2.0 V	Resonator connection		160	420	μΑ
			Subsystem	fsub = 32.768 kHz <sup>Note 5</sup>	Square wave input		0.28	0.61	μΑ
			clock operation	T <sub>A</sub> = -40°C	Resonator connection		0.47	0.80	μΑ
				fsub = 32.768 kHz <sup>Note 5</sup>	Square wave input		0.34	0.61	μΑ
				T <sub>A</sub> = +25°C	Resonator connection		0.53	0.80	μΑ
				fsub = 32.768 kHz <sup>Note 5</sup>	Square wave input		0.41	2.30	μΑ
				T <sub>A</sub> = +50°C	Resonator connection		0.60	2.49	μΑ
				fsub = 32.768 kHz <sup>Note 5</sup>	Square wave input		0.64	4.03	μΑ
				T <sub>A</sub> = +70°C	Resonator connection		0.83	4.22	μА
				fsub = 32.768 kHz <sup>Note 5</sup>	Square wave input		1.09	8.04	μΑ
			T <sub>A</sub> = +85°C	Resonator connection		1.28	8.23	μА	
	IDD3 <sup>Note 6</sup>	STOP	T <sub>A</sub> = -40°C	•	•		0.19	0.52	μΑ
		mode <sup>Note 8</sup>	T <sub>A</sub> = +25°C				0.25	0.52	μΑ
		-	T <sub>A</sub> = +50°C				0.32	2.21	μΑ
			T <sub>A</sub> = +70°C				0.55	3.94	μΑ
			T <sub>A</sub> = +85°C			1.00	7.95	μA	

(Notes and Remarks are listed on the next page.)



- **6.** Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC when the A/D converter operates in an operation mode or the HALT mode.
- 7. Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
- 8. Current flowing only during data flash rewrite.
- 9. Current flowing only during self programming.
- 10. For shift time to the SNOOZE mode, see 18.3.3 SNOOZE mode.
- Remarks 1. fil: Low-speed on-chip oscillator clock frequency
  - 2. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
  - 3. fclk: CPU/peripheral hardware clock frequency
  - **4.** Temperature condition of the TYP. value is  $T_A = 25^{\circ}C$



# (4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input) (2/2)

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{DD0} = \text{EV}_{DD1} \le \text{V}_{DD} \le 5.5 \text{ V}, \text{Vss} = \text{EV}_{SS0} = \text{EV}_{SS1} = 0 \text{ V})$ 

Parameter	Symbo		Conditions	HS (high main)		LS (low-sp Mo	,	LV (low-vol		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SIp setup time (to SCKp↑) Note 1	tsık2	2.7 V ≤ E	$2.7~V \leq EV_{DD0} \leq 5.5~V$			1/fмск+30		1/fмск+30		ns
1.8		1.8 V ≤ E	$EV_{DD0} \le 5.5 \text{ V}$	1/fмск+3 0		1/fмск+30		1/fмск+30		ns
		1.7 V ≤ E	$EV_{DD0} \le 5.5 \text{ V}$	1/fмск+4 0		1/fмск+40		1/fмск+40		ns
		1.6 V ≤	EV <sub>DD0</sub> ≤ 5.5 V	_		1/fмск+40		1/fмск+40		ns
Slp hold time (from SCKp↑)	tksi2	1.8 V ≤ E	EV <sub>DD0</sub> ≤ 5.5 V	1/fмск+3 1		1/fмск+31		1/fмск+31		ns
Note 2		1.7 V ≤ E	EV <sub>DD0</sub> ≤ 5.5 V	1/fмск+ 250		1/fмск+ 250		1/fмск+ 250		ns
		1.6 V ≤	$EV_{DD0} \le 5.5 V$	_		1/fмск+ 250		1/fмск+ 250		ns
Delay time from SCKp↓ to	tkso2	C = 30 pF Note 4	$2.7~V \leq EV_{DD0} \leq 5.5$ V		2/f <sub>MCK+</sub> 44		2/f <sub>MCK+</sub> 110		2/f <sub>MCK+</sub> 110	ns
SOp output Note			$2.4~V \le EV_{DD0} \le 5.5$ V		2/fмск+ 75		2/fмск+ 110		2/fмск+ 110	ns
			$1.8~V \le EV_{DD0} \le 5.5$ V		2/fмск+ 110		2/fмск+ 110		2/fмск+ 110	ns
			1.7 V ≤ EV <sub>DD0</sub> ≤ 5.5 V		2/fмск+ 220		2/fмск+ 220		2/fмск+ 220	ns
			1.6 V ≤ EV <sub>DD0</sub> ≤ 5.5 V		_		2/fмск+ 220		2/fмск+ 220	ns

- **Notes 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time becomes "to SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 2. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 3. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 4. C is the load capacitance of the SOp output lines.
  - 5. Transfer rate in the SNOOZE mode: MAX. 1 Mbps

Caution Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

- **Remarks 1.** p: CSI number (p = 00, 01, 10, 11, 20, 21, 30, 31), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3), g: PIM number (g = 0, 1, 4, 5, 8, 14)
  - 2. fmck: Serial array unit operation clock frequency

    (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

    n: Channel number (mn = 00 to 03, 10 to 13))

# (8) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output) (3/3)

 $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.8 \text{ V} \le \text{EV}_{\text{DD0}} = \text{EV}_{\text{DD1}} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = \text{EV}_{\text{SS1}} = 0 \text{ V})$ 

Parameter	Symbol	Conditions	, 0	h-speed Mode	,	/-speed Mode	,	-voltage Mode	Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SIp setup time (to SCKp↓) Note 1	tsıĸı	$\begin{array}{l} 4.0~V \leq EV_{DD0} \leq 5.5~V, \\ 2.7~V \leq V_b \leq 4.0~V, \end{array} \label{eq:pdd_pdd}$	44		110		110		ns
		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$							
			44		110		110		ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$							
		$ \begin{array}{c} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note 2}}, \end{array} $	110		110		110		ns
		$C_b = 30 \text{ pF}, R_b = 5.5 \text{ k}\Omega$							
SIp hold time (from SCKp↓) Note 1	<b>t</b> KSI1	$ 4.0 \ V \leq EV_{DD0} \leq 5.5 \ V, \\ 2.7 \ V \leq V_b \leq 4.0 \ V, $	19		19		19		ns
		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$							
			19		19		19		ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$							
		$\begin{array}{c} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note 2}}, \end{array}$	19		19		19		ns
		$C_b = 30 \text{ pF}, R_b = 5.5 \text{ k}\Omega$							
Delay time from SCKp↑ to	tkso1	$ \begin{array}{l} 4.0 \; V \leq EV_{DD0} \leq 5.5 \; V, \\ 2.7 \; V \leq V_b \leq 4.0 \; V, \end{array} $		25		25		25	ns
SOp output Note 1		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$							
		$ \begin{array}{c} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \end{array} $		25		25		25	ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$							
		$\begin{array}{c} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note 2}}, \end{array}$		25		25		25	ns
		$C_b = 30$ pF, $R_b = 5.5$ k $\Omega$							

Notes

- 1. When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
- 2. Use it with  $EV_{DD0} \ge V_b$ .

Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (When 20- to 52-pin products)/EVDD tolerance (When 64- to 128-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

# 2.5.2 Serial interface IICA

# (1) I2C standard mode

(Ta = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, Vss = EVss0 = EVss1 = 0 V)

Parameter	Symbol	С	Conditions	, ,	h-speed Mode	,	/-speed Mode	,	-voltage Mode	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fscL	Standard	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.5 \text{ V}$	0	100	0	100	0	100	kHz
		mode:	1.8 V ≤ EV <sub>DD0</sub> ≤ 5.5 V	0	100	0	100	0	100	kHz
		fc∟k≥ 1 MHz	1.7 V ≤ EV <sub>DD0</sub> ≤ 5.5 V	0	100	0	100	0	100	kHz
			1.6 V ≤ EV <sub>DD0</sub> ≤ 5.5 V	_	_	0	100	0	100	kHz
Setup time of restart	tsu:sta	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
condition		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	4.7		4.7		μS
Hold time <sup>Note 1</sup>	thd:STA	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	4.0		4.0		μS
Hold time when SCLA0 =	tLOW	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
" <u>L</u> "		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	4.7		4.7		μS
Hold time when SCLA0 = t	<b>t</b> HIGH	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
"H"		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	4.0		4.0		μS
Data setup time	tsu:dat	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	250		250		250		ns
(reception)		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	250		250		250		ns
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	250		250		250		ns
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	250		250		ns
Data hold time	thd:dat	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	0	3.45	0	3.45	0	3.45	μS
(transmission) <sup>Note 2</sup>		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	0	3.45	0	3.45	0	3.45	μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	0	3.45	0	3.45	0	3.45	μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_	_	0	3.45	0	3.45	μS
Setup time of stop	tsu:sto	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
condition		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.0		4.0		4.0		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V			4.0		4.0		μS
Bus-free time	<b>t</b> BUF	2.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.8 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.7 V ≤ EV <sub>DD0</sub> :	≤ 5.5 V	4.7		4.7		4.7		μS
		1.6 V ≤ EV <sub>DD0</sub> ≤	≤ 5.5 V	_		4.7		4.7		μS

(Notes, Caution and Remark are listed on the next page.)



#### (2) I2C fast mode

(Ta = -40 to +85°C, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD  $\leq$  5.5 V, Vss = EVss0 = EVss1 = 0 V)

Parameter	Symbol	Сог	nditions	HS (high- main) N				`	-voltage Mode	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fscL	Fast mode:	$2.7~V \le EV_{DD0} \le 5.5~V$	0	400	0	400	0	400	kHz
		fc∟κ≥ 3.5 MHz	1.8 V ≤ EV <sub>DD0</sub> ≤ 5.5 V	0	400	0	400	0	400	kHz
Setup time of restart	tsu:sta	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
condition		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
Hold time <sup>Note 1</sup>	thd:sta	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
Hold time when SCLA0 =	tLOW	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	2.7 V ≤ EV <sub>DD0</sub> ≤ 5.5 V			1.3		1.3		μS
" <u>L</u> "		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	1.3		1.3		1.3		μS
Hold time when SCLA0 =	<b>t</b> HIGH	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
"H"		1.8 V ≤ EV <sub>DD0</sub> ≤ 5.8	5 V	0.6		0.6		0.6		μS
Data setup time	tsu:dat	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	100		100		100		μS
(reception)		1.8 V ≤ EV <sub>DD0</sub> ≤ 5.8	5 V	100		100		100		μS
Data hold time	thd:dat	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0	0.9	0	0.9	0	0.9	μS
(transmission)Note 2		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0	0.9	0	0.9	0	0.9	μS
Setup time of stop	tsu:sto	$2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.$	5 V	0.6		0.6		0.6		μS
condition		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	0.6		0.6		0.6		μS
Bus-free time	<b>t</b> BUF	$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	1.3		1.3		1.3		μS
		$1.8 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.8$	5 V	1.3		1.3		1.3		μS

Notes 1. The first clock pulse is generated after this period when the start/restart condition is detected.

2. The maximum value (MAX.) of thd:DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

Caution The values in the above table are applied even when bit 2 (PIOR2) in the peripheral I/O redirection register (PIOR) is 1. At this time, the pin characteristics (IoH1, IoL1, VOH1, VOL1) must satisfy the values in the redirect destination.

**Remark** The maximum value of Cb (communication line capacitance) and the value of Rb (communication line pull-up resistor) at that time in each mode are as follows.

Fast mode:  $C_b = 320 \text{ pF}, R_b = 1.1 \text{ k}\Omega$ 

<R>

(4) When reference voltage (+) = Internal reference voltage (ADREFP1 = 1, ADREFP0 = 0), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target pin : ANI0, ANI2 to ANI14, ANI16 to ANI26

(Ta = -40 to +85°C, 2.4 V  $\leq$  VDD  $\leq$  5.5 V, 1.6 V  $\leq$  EVDD0 = EVDD1  $\leq$  VDD, Vss = EVss0 = EVss1 = 0 V, Reference voltage (+) = VBGR Note 3, Reference voltage (-) = AVREFM = 0 V Note 4, HS (high-speed main) mode)

Parameter	Symbol	Co	nditions	MIN.	TYP.	MAX.	Unit
Resolution	RES				8		bit
Conversion time	tconv	8-bit resolution	$2.4~V \leq V_{DD} \leq 5.5~V$	17		39	μS
Zero-scale error <sup>Notes 1, 2</sup>	Ezs	8-bit resolution	$2.4~V \leq V_{DD} \leq 5.5~V$			±0.60	%FSR
Integral linearity error <sup>Note 1</sup>	ILE	8-bit resolution	$2.4~V \leq V_{DD} \leq 5.5~V$			±2.0	LSB
Differential linearity error Note 1	DLE	8-bit resolution	$2.4~V \leq V_{DD} \leq 5.5~V$			±1.0	LSB
Analog input voltage	VAIN			0		V <sub>BGR</sub> Note 3	٧

- **Notes 1.** Excludes quantization error ( $\pm 1/2$  LSB).
  - 2. This value is indicated as a ratio (%FSR) to the full-scale value.
  - 3. Refer to 2.6.2 Temperature sensor/internal reference voltage characteristics.
  - 4. When reference voltage (-) = Vss, the MAX. values are as follows.
    Zero-scale error: Add ±0.35%FSR to the MAX. value when reference voltage (-) = AVREFM.
    Integral linearity error: Add ±0.5 LSB to the MAX. value when reference voltage (-) = AVREFM.
    Differential linearity error: Add ±0.2 LSB to the MAX. value when reference voltage (-) = AVREFM.

# (2) Flash ROM: 96 to 256 KB of 30- to 100-pin products (Ta = -40 to $+105^{\circ}$ C, 2.4 V $\leq$ EV<sub>DD0</sub> = EV<sub>DD1</sub> $\leq$ V<sub>DD</sub> $\leq$ 5.5 V, Vss = EV<sub>SS0</sub> = EV<sub>SS1</sub> = 0 V) (1/2)

Parameter	Symbol			Conditions			MIN.	TYP.	MAX.	Unit									
Supply	I <sub>DD1</sub>	Operating	HS (high-	fin = 32 MHz <sup>Note 3</sup>	Basic	V <sub>DD</sub> = 5.0 V		2.3		mA									
Current Note 1		mode	speed main) mode Note 5		operatio n	V <sub>DD</sub> = 3.0 V		2.3		mA									
					Normal	V <sub>DD</sub> = 5.0 V		5.2	9.2	mA									
					operatio n	V <sub>DD</sub> = 3.0 V		5.2	9.2	mA									
				fin = 24 MHz <sup>Note 3</sup>	Normal	V <sub>DD</sub> = 5.0 V		4.1	7.0	mA									
					operatio n	V <sub>DD</sub> = 3.0 V		4.1	7.0	mA									
				fih = 16 MHz <sup>Note 3</sup>	Normal	V <sub>DD</sub> = 5.0 V		3.0	5.0	mA									
					operatio n	V <sub>DD</sub> = 3.0 V		3.0	5.0	mA									
			HS (high-	$f_{MX} = 20 \text{ MHz}^{\text{Note 2}},$	Normal	Square wave input		3.4	5.9	mA									
			speed main) mode Note 5	V <sub>DD</sub> = 5.0 V	operatio n	Resonator connection		3.6	6.0	mA									
			1 1	Normal	Square wave input		3.4	5.9	mA										
						V <sub>DD</sub> = 3.0 V	operatio n	Resonator connection		3.6	6.0	mA							
				$f_{MX} = 10 \text{ MHz}^{\text{Note 2}},$	Normal	Square wave input		2.1	3.5	mA									
		V <sub>DD</sub> = 5.0 V	operatio n	Resonator connection		2.1	3.5	mA											
			$f_{MX} = 10 \text{ MHz}^{\text{Note 2}},$	Normal	Square wave input		2.1	3.5	mA										
				\										V <sub>DD</sub> = 3.0 V	operatio n	Resonator connection		2.1	3.5
			Subsystem	fsuв = 32.768 kHz	Normal	Square wave input		4.8	5.9	μА									
			clock operation		Note 4 $T_A = -40^{\circ}C$	operatio n	Resonator connection		4.9	6.0	μΑ								
				fsuв = 32.768 kHz	Normal	Square wave input		4.9	5.9	μΑ									
				Note 4  TA = +25°C	operatio n	Resonator connection		5.0	6.0	μΑ									
				fsuв = 32.768 kHz	Normal	Square wave input		5.0	7.6	μΑ									
				Note 4 $T_A = +50^{\circ}C$	operatio n	Resonator connection		5.1	7.7	μΑ									
				fsuв = 32.768 kHz	Normal	Square wave input		5.2	9.3	μA									
				Note 4 $T_A = +70^{\circ}C$	operatio n	Resonator connection		5.3	9.4	μΑ									
				fsuB = 32.768 kHz	Normal	Square wave input		5.7	13.3	μΑ									
			Note 4  TA = +85°C	operatio n	Resonator connection		5.8	13.4	μΑ										
				fsuв = 32.768 kHz	Normal	Square wave input		10.0	46.0	μΑ									
				Note 4  TA = +105°C	operatio n	Resonator connection		10.0	46.0	μA									

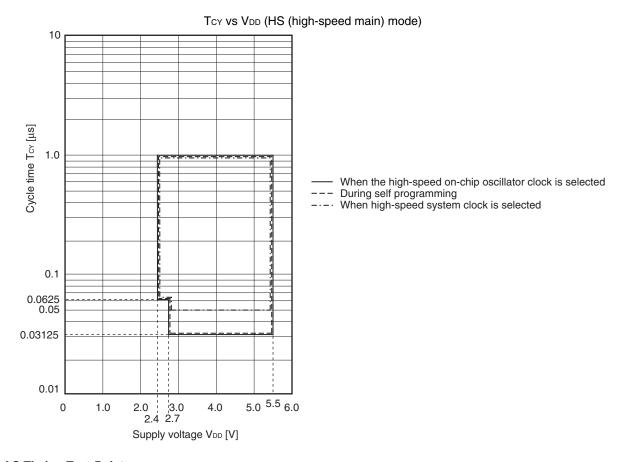
(Notes and Remarks are listed on the next page.)

- Notes 1. Total current flowing into VDD, EVDDO, and EVDD1, including the input leakage current flowing when the level of the input pin is fixed to VDD, EVDDO, and EVDD1, or Vss, EVSSO, and EVSS1. The values below the MAX. column include the peripheral operation current. However, not including the current flowing into the A/D converter, LVD circuit, I/O port, and on-chip pull-up/pull-down resistors and the current flowing during data flash rewrite.
  - 2. During HALT instruction execution by flash memory.
  - 3. When high-speed on-chip oscillator and subsystem clock are stopped.
  - 4. When high-speed system clock and subsystem clock are stopped.
  - **5.** When high-speed on-chip oscillator and high-speed system clock are stopped. When RTCLPC = 1 and setting ultra-low current consumption (AMPHS1 = 1). The current flowing into the RTC is included. However, not including the current flowing into the 12-bit interval timer and watchdog timer.
  - 6. Not including the current flowing into the RTC, 12-bit interval timer, and watchdog timer.
  - 7. Relationship between operation voltage width, operation frequency of CPU and operation mode is as below.

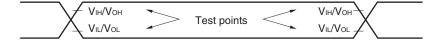
HS (high-speed main) mode:  $2.7 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V} @ 1 \text{ MHz}$  to 32 MHz  $2.4 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V} @ 1 \text{ MHz}$  to 16 MHz

- 8. Regarding the value for current operate the subsystem clock in STOP mode, refer to that in HALT mode.
- Remarks 1. fmx: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)
  - 2. fin: High-speed on-chip oscillator clock frequency
  - 3. fsub: Subsystem clock frequency (XT1 clock oscillation frequency)
  - **4.** Except subsystem clock operation and STOP mode, temperature condition of the TYP. value is  $T_A = 25^{\circ}C$

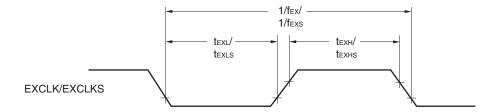
# Minimum Instruction Execution Time during Main System Clock Operation



## **AC Timing Test Points**



### **External System Clock Timing**



# (3) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input) $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} = \text{EV}_{\text{DD1}} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = \text{EV}_{\text{SS1}} = 0 \text{ V})$

Parameter	Symbol	Conditions		HS (high-speed main) Mode		Unit
				MIN.	MAX.	
SCKp cycle time Note 5	tkcy2	$4.0~V \leq EV_{DD0} \leq 5.5$ V	20 MHz < fмск	16/fмск		ns
			fмcк ≤ 20 MHz	12/fмск		ns
		$2.7~V \le EV_{DD0} \le 5.5$ V	16 MHz < fмск	16/fмск		ns
			fмck ≤ 16 MHz	12/fмск		ns
		2.4 V ≤ EV <sub>DD0</sub> ≤ 5.5 V		16/fмск		ns
				12/fмcк and 1000		ns
SCKp high-/low-level	<b>t</b> кн2,	$4.0~V \leq EV_{DD0} \leq 5.5~V$		tkcy2/2 – 14		ns
width	t <sub>KL2</sub>	2.7 V ≤ EV <sub>DD0</sub> ≤ 5.5 V		tkcy2/2 – 16		ns
		$2.4~V \leq EV_{DD0} \leq 5.5~V$		tkcy2/2 - 36		ns
SIp setup time (to SCKp↑) Note 1	tsık2	$2.7~V \leq EV_{\text{DD0}} \leq 5.5~V$		1/fмск+40		ns
		$2.4~V \leq EV_{DD0} \leq 5.5~V$		1/fмск+60		ns
SIp hold time (from SCKp↑) Note 2	tksi2	$2.4~V \leq EV_{DD0} \leq 5.5~V$		1/fмск+62		ns
Delay time from SCKp↓ to SOp output	tkso2	C = 30 pF Note 4	$2.7~V \leq EV_{DD0} \leq 5.5$ $V$		2/fмск+66	ns
			$2.4~V \leq EV_{DD0} \leq 5.5$ V		2/fмск+113	ns

- **Notes 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time becomes "to SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 2. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 3. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
  - 4. C is the load capacitance of the SOp output lines.
  - 5. Transfer rate in the SNOOZE mode: MAX. 1 Mbps

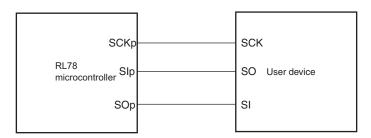
Caution Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

- **Remarks 1.** p: CSI number (p = 00, 01, 10, 11, 20, 21, 30, 31), m: Unit number (m = 0, 1), n: Channel number (n = 0 to 3), g: PIM number (g = 0, 1, 4, 5, 8, 14)
  - 2. fmck: Serial array unit operation clock frequency

    (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

    n: Channel number (mn = 00 to 03, 10 to 13))

#### CSI mode connection diagram (during communication at same potential)





# (6) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output) (3/3)

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} = \text{EV}_{\text{DD1}} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = \text{EV}_{\text{SS1}} = 0 \text{ V})$ 

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SIp setup time (to SCKp↓) <sup>Note</sup>	tsıĸı	$4.0 \ V \leq EV_{DD} \leq 5.5 \ V, \ 2.7 \ V \leq V_b \leq 4.0 \ V,$	88		ns
		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$			
		$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V}, \ 2.3 \text{ V} \le \text{V}_{\text{b}} \le 2.7 \text{ V},$	88		ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$			
		$2.4 \ V \le EV_{DD0} < 3.3 \ V, \ 1.6 \ V \le V_b \le 2.0 \ V,$	220		ns
		$C_b = 30 \text{ pF}, R_b = 5.5 \text{ k}\Omega$			
SIp hold time	tksii	$4.0~V \leq EV_{\text{DD0}} \leq 5.5~V,~2.7~V \leq V_{\text{b}} \leq 4.0~V,$	38		ns
(from SCKp↓) <sup>Note</sup>		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$			
		$2.7 \; V \leq EV_{\text{DD0}} < 4.0 \; V, \; 2.3 \; V \leq V_{\text{b}} \leq 2.7 \; V,$	38		ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$			
		$2.4~V \leq EV_{DD0} < 3.3~V,~1.6~V \leq V_b \leq 2.0~V,$	38		ns
		$C_b = 30 \text{ pF}, R_b = 5.5 \text{ k}\Omega$			
Delay time from SCKp↑ to	tkso1	$4.0~V \leq EV_{\text{DD0}} \leq 5.5~V,~2.7~V \leq V_{\text{b}} \leq 4.0~V,$		50	ns
SOp output Note		$C_b = 30 \text{ pF}, R_b = 1.4 \text{ k}\Omega$			
		$2.7 \; V \leq EV_{\text{DD0}} < 4.0 \; V, \; 2.3 \; V \leq V_{\text{b}} \leq 2.7 \; V,$		50	ns
		$C_b = 30 \text{ pF}, R_b = 2.7 \text{ k}\Omega$			
		$2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V}, \ 1.6 \text{ V} \le \text{V}_{\text{b}} \le 2.0 \text{ V},$		50	ns
		$C_b=30~pF,~R_b=5.5~k\Omega$			

**Note** When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (V<sub>DD</sub> tolerance (for the 20- to 52-pin products)/EV<sub>DD</sub> tolerance (for the 64- to 100-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

# (7) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (slave mode, SCKp... external clock input)

 $(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD0}} = \text{EV}_{\text{DD1}} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{Vss} = \text{EV}_{\text{SS0}} = \text{EV}_{\text{SS1}} = 0 \text{ V})$ 

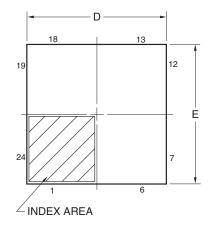
Parameter	Symbol	Conditions		HS (high-speed main) Mode		Unit
				MIN.	MAX.	
SCKp cycle time Note 1	tkcy2	$4.0~V \leq EV_{DD0} \leq 5.5$	24 MHz < fмск	28/fмск		ns
		V,	20 MHz < fмcк ≤ 24 MHz	24/fмск		ns
		$2.7 \text{ V} \le V_b \le 4.0 \text{ V}$	8 MHz < fмck ≤ 20 MHz	20/fмск		ns
			4 MHz < fmck ≤ 8 MHz	16/fмск		ns
			fмcк ≤ 4 MHz	12/fмск		ns
		$2.7 \text{ V} \le \text{EV}_{\text{DDO}} < 4.0 \text{ V},$	24 MHz < fмск	40/fмск		ns
			$20~\text{MHz} < \text{fmck} \le 24~\text{MHz}$	32/fмск		ns
		$2.3 \ V \leq V_b \leq 2.7 \ V$	16 MHz < fмcк ≤ 20 MHz	28/fмск		ns
			8 MHz < fмcк ≤ 16 MHz	24/fмск		ns
			4 MHz < fмcк ≤ 8 MHz	16/fмск		ns
			fмcк ≤ 4 MHz	12/fмск		ns
		$2.4~V \le EV_{DD0} < 3.3$	24 MHz < fмск	96/fмск		ns
		V,	20 MHz < fмcк ≤ 24 MHz	72/fмск		ns
		$1.6 \ V \le V_b \le 2.0 \ V$	16 MHz < fмcк ≤ 20 MHz	64/fмск		ns
			8 MHz < fмcк ≤ 16 MHz	52/fмск		ns
			4 MHz < fмcк ≤ 8 MHz	32/fмск		ns
			fмcк ≤ 4 MHz	20/fмск		ns
SCKp high-/low-level width	$ \begin{array}{c} t_{\text{KL2}} \\ \hline \\ 2.7 \text{ V} \leq V_b \leq \\ \hline \\ 2.3 \text{ V} \leq V_b \leq \\ \hline \\ 2.4 \text{ V} \leq EV_{DI} \\ \hline \end{array} $	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ $2.7 \text{ V} \le \text{V}_{\text{b}} \le 4.0 \text{ V}$		tксу2/2 – 24		ns
		$2.7 \ V \le EV_{DD0} < 4.$ $2.3 \ V \le V_b \le 2.7 \ V$		tkcy2/2 - 36		ns
		$2.4 \ V \le EV_{DD0} < 3.$ $1.6 \ V \le V_b \le 2.0 \ V$		tkcy2/2 - 100		ns
SIp setup time (to SCKp↑) Note2	tsık2	$ 4.0 \ V \le EV_{DD0} \le 5.5 \ V, $ $ 2.7 \ V \le V_b \le 4.0 \ V $		1/fмск + 40		ns
		$ 2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V}, \\ 2.3 \text{ V} \le \text{V}_{\text{b}} \le 2.7 \text{ V} $		1/fмск + 40		ns
		$2.4 \ V \le EV_{DD0} < 3.$ $1.6 \ V \le V_b \le 2.0 \ V$				ns
Slp hold time (from SCKp <sup>↑</sup> ) Note 3	tksi2			1/fmck + 62		ns
Delay time from SCKp↓ to SOp output Note 4	tkso2	$ 4.0~V \leq EV_{DD0} \leq 5.5~V,~2.7~V \leq V_b \leq 4.0~V, $ $C_b = 30~pF,~R_b = 1.4~k\Omega $			2/fмск + 240	ns
		$ 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \; 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 30 \; pF, \; R_b = 2.7 \; k\Omega $			2/fмск + 428	ns
		$2.4 \ V \le EV_{DD0} < 3.$ $C_b = 30 \ pF, \ R_b = 5$	3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V .5 kΩ		2/fмск + 1146	ns

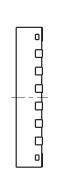
(Notes, Caution and Remarks are listed on the next page.)

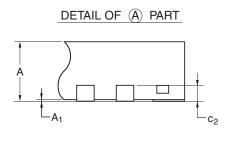
### 4.2 24-pin Products

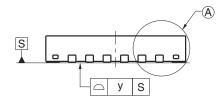
R5F1007AANA, R5F1007CANA, R5F1007DANA, R5F1007EANA R5F1017AANA, R5F1017CANA, R5F1017DANA, R5F1017EANA R5F1007ADNA, R5F1007CDNA, R5F1007DDNA, R5F1007EDNA R5F1007AGNA, R5F1007CGNA, R5F1007DGNA, R5F1007EGNA

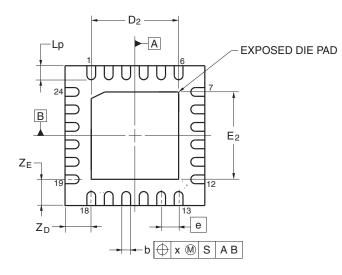
JEITA Package code	RENESAS code	Previous code	MASS(TYP.)[g]	
P-HWQFN24-4x4-0.50	PWQN0024KE-A	P24K8-50-CAB-3	0.04	









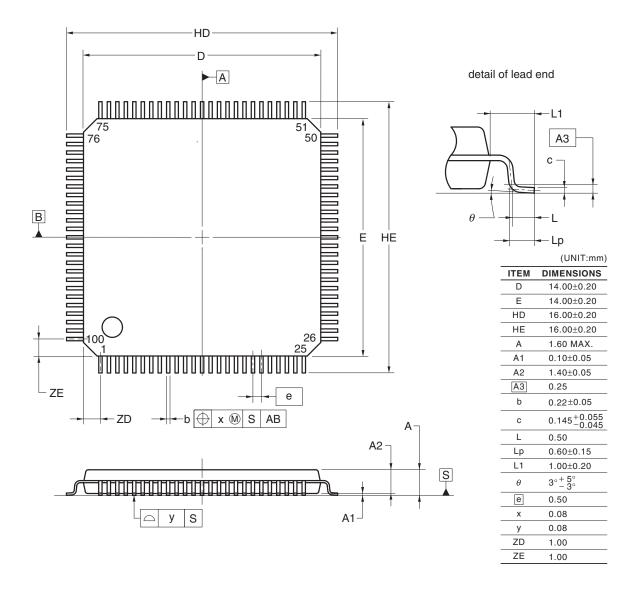


Referance	Dimension in Millimeters			
Symbol	Min	Nom	Max	
D	3.95	4.00	4.05	
E	3.95	4.00	4.05	
А			0.80	
A <sub>1</sub>	0.00			
b	0.18	0.25	0.30	
е	_	0.50	_	
Lp	0.30	0.40	0.50	
х	_		0.05	
у	_		0.05	
Z <sub>D</sub>		0.75		
Z <sub>E</sub>		0.75		
C <sub>2</sub>	0.15	0.20	0.25	
D <sub>2</sub>		2.50		
E <sub>2</sub>		2.50		

### 4.13 100-pin Products

R5F100PFAFB, R5F100PGAFB, R5F100PHAFB, R5F100PJAFB, R5F100PKAFB, R5F100PLAFB R5F101PFAFB, R5F101PGAFB, R5F101PHAFB, R5F101PJAFB, R5F101PKAFB, R5F101PLAFB R5F100PFDFB, R5F100PGDFB, R5F100PHDFB, R5F100PJDFB, R5F100PKDFB, R5F101PGDFB, R5F101PGDFB, R5F101PJDFB, R5F101PJDFB, R5F101PLDFB R5F100PFGFB, R5F100PGGFB, R5F100PHGFB, R5F100PJGFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]	
P-LFQFP100-14x14-0.50	PLQP0100KE-A	P100GC-50-GBR-1	0.69	



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